Search Notes



Application/Control No.	Applicant(s)/Pate	Applicant(s)/Patent under Reexamination	
10/714,191	FRITSCH, JOHN		
Examiner	Art Unit		
Jack W. Lavinder	3677		

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	interference see notes	9/20/2008	/JL/	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
updated search	9/20/2008	/JL/	